



Ponciano, V., Pires, I. M., Ribeiro, F. R., Marques, G., Garcia, N. M., Pombo, N., Spinsante, S., Zdravevski, E. (2020). Is The Timed-Up and Go Test Feasible in Mobile Devices? A Systematic Review. *Electronics*, 9(3), 528. <https://doi.org/10.3390/electronics9030528>